

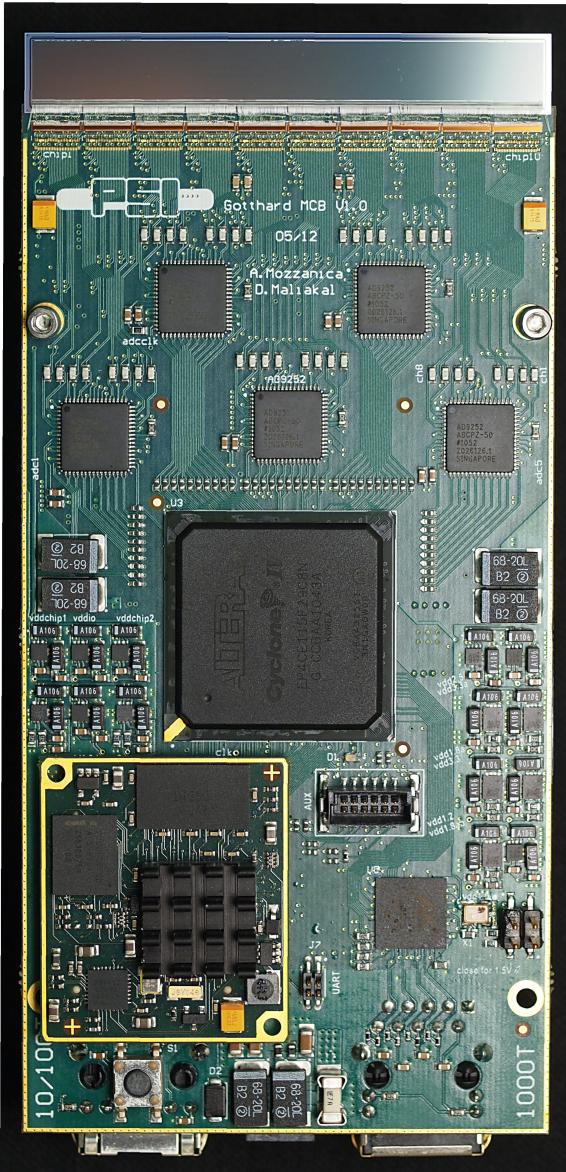
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GotthardII development status

XDAC Meeting, 16.05.2017



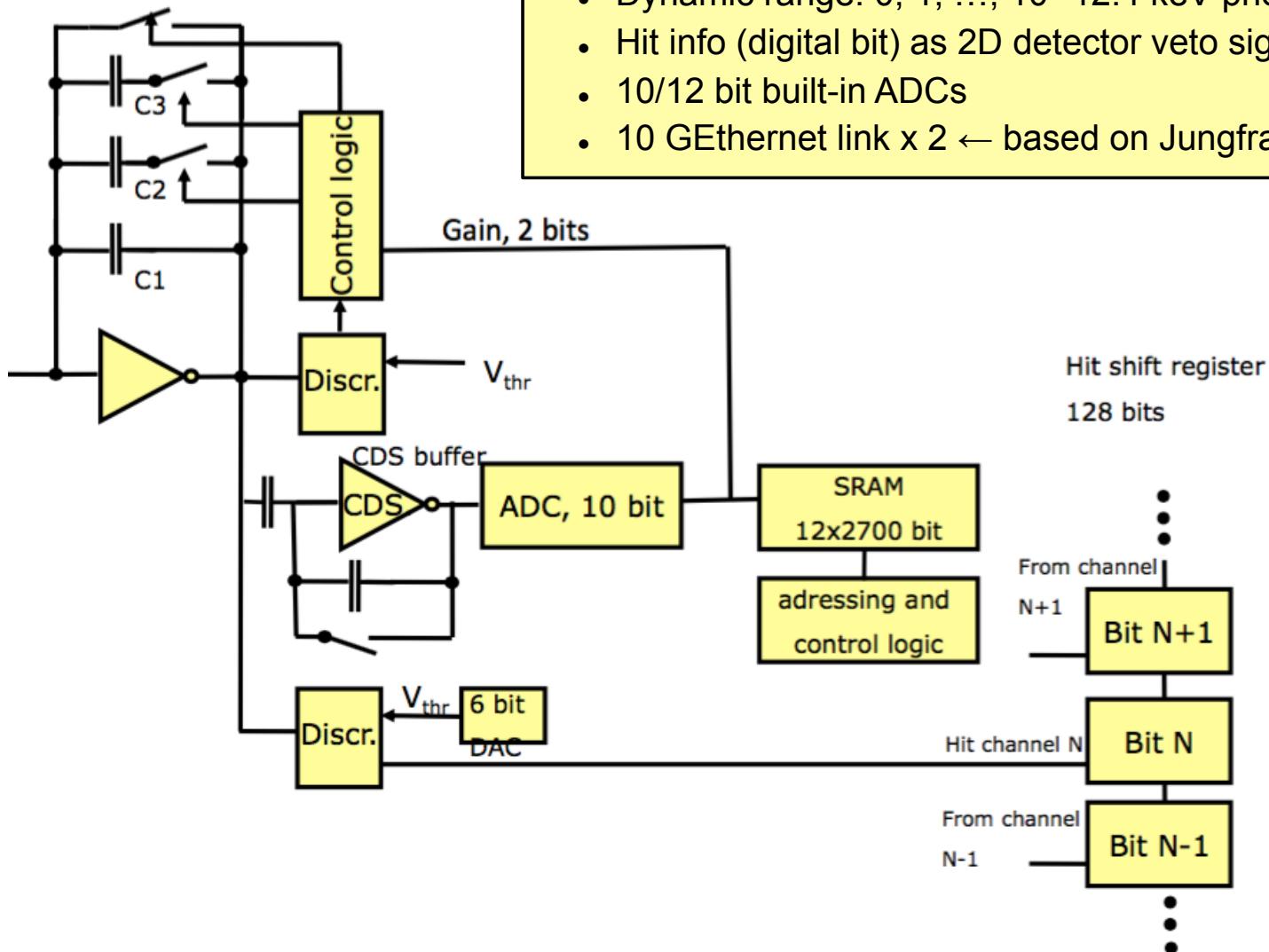
- 67mm x 130mm
- 50 μm pitch, 1280ch/module (same as MYTHEN)
- 10 chips, 4 analog outputs per chip
- 40 ADC channels @32Mhz,14bits
- Gbit Ethernet data transfer for readout
- 100M Ethernet for slow control/setup
- Fast readout (1MHz) with ~600 bunches per EU-XFEL train measurable (memory for ~350)
- 60kHz continuous frame rate
- Integration in detector class for software control (same as Jungfrau)
- Developed in collaboration with Desy
- Start with GotthardI and replace it with GotthardII



Outline

- Gotthard-II
- Gotthard-1.7 front-end characterization
- ADC 0.2 characterisation
- New submission (March 17)
- Summary

Reminder of Gotthard-II: Schematic



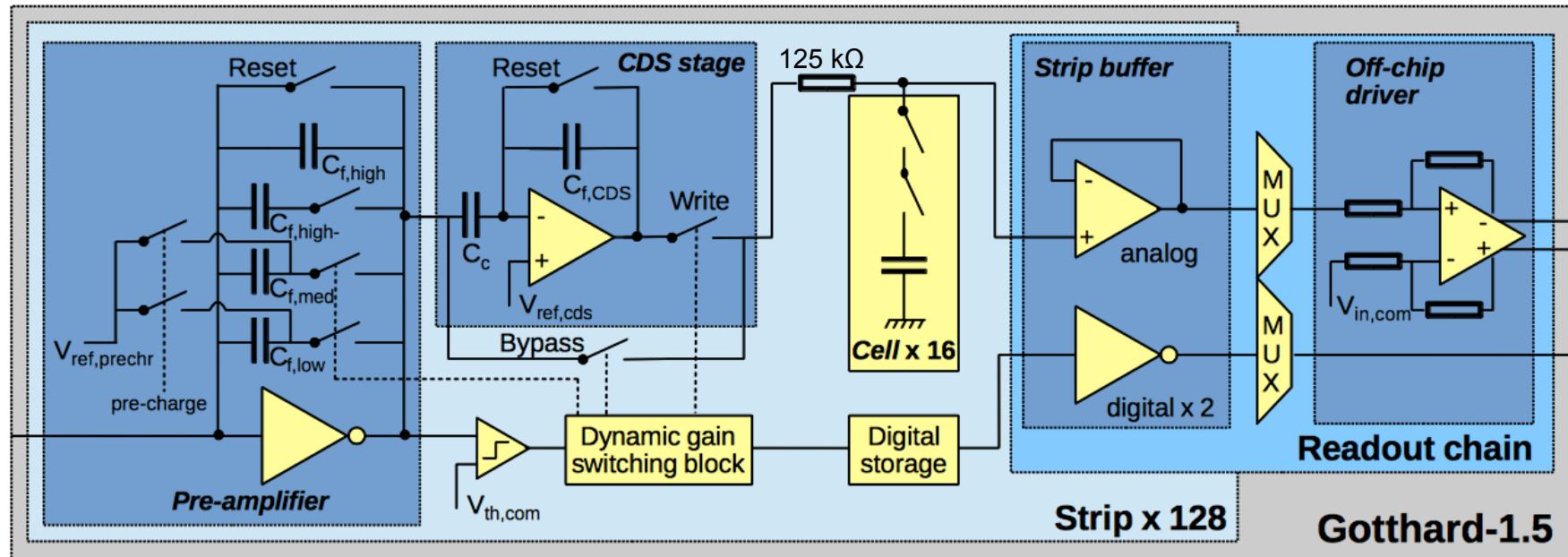
Gotthard-1.4&1.5 analogue FE

Key features:

- Copied from Jungfrau, preamp scaled for strips

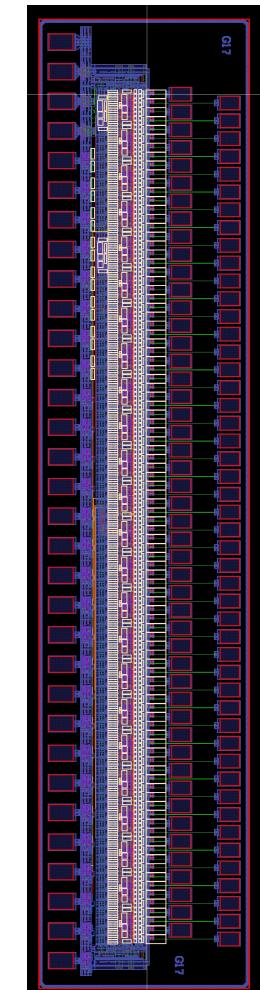
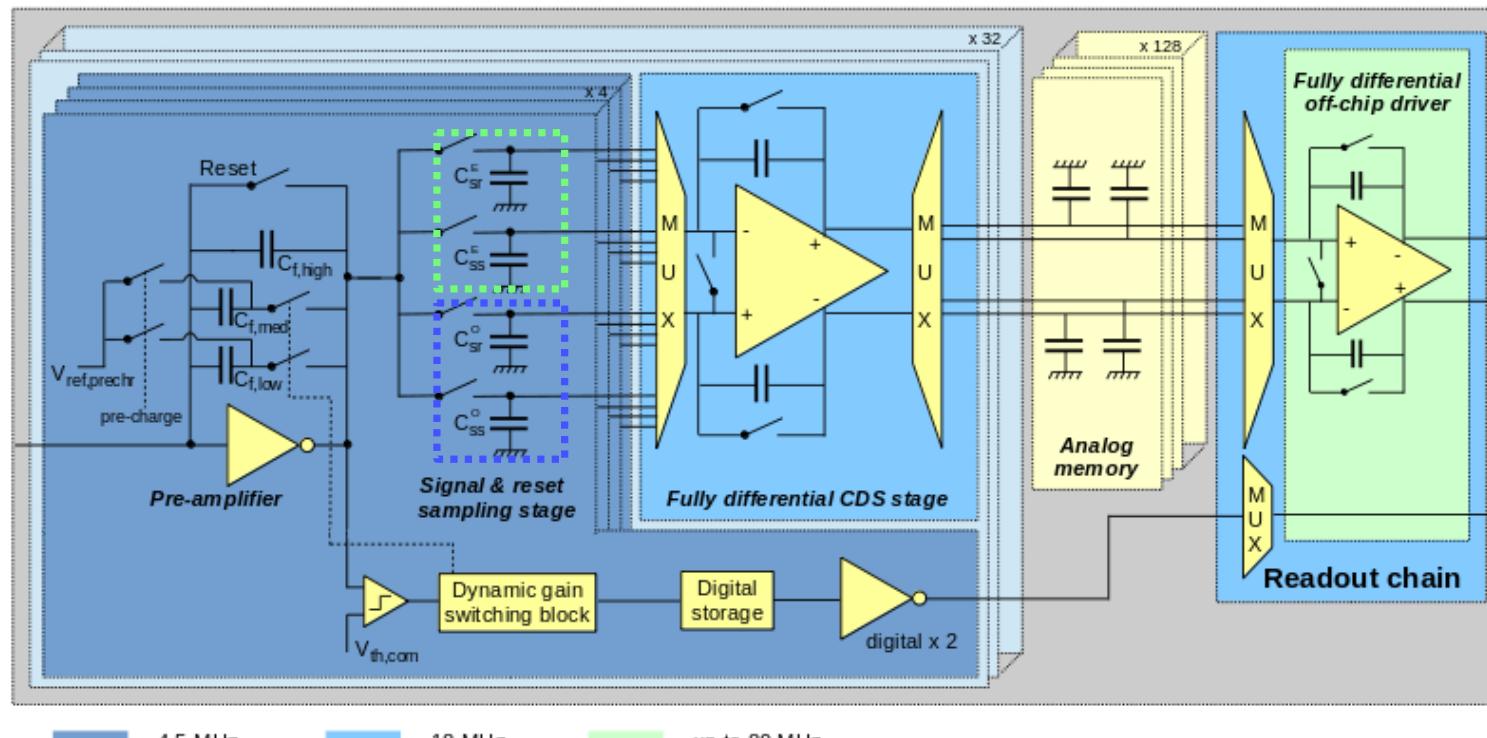
Main problems:

- To slow
- To small DC gain → high capacitive crosstalk



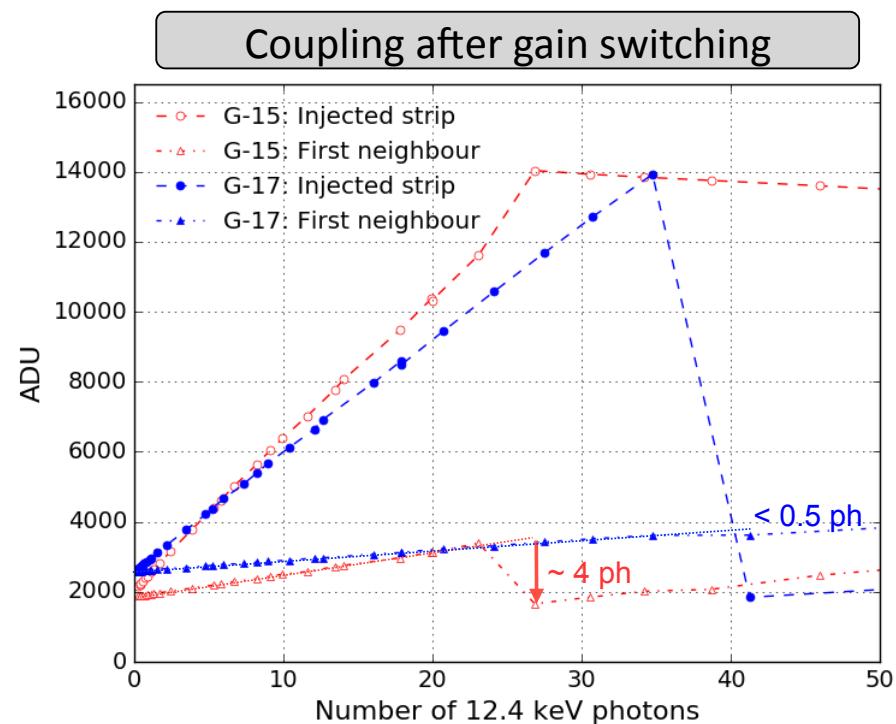
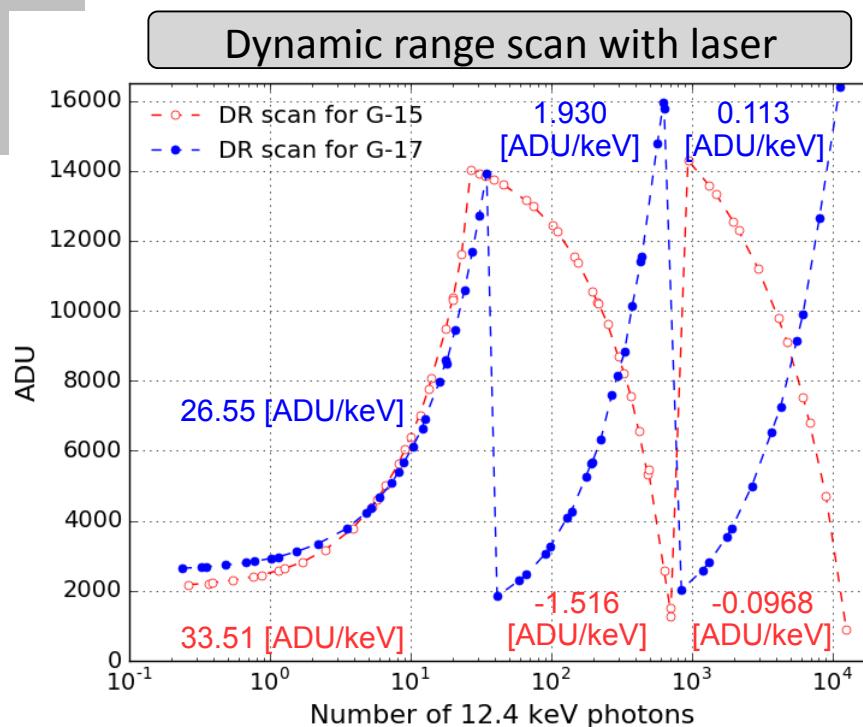
Gotthard 1.7 analogue FE

- Development of high DC gain, fully differential front-end G-1.7
 - High DC gain pre-amplifier (700-950)
 - Continuous CDS sampling at > 18 MHz
 - Fully differential output to match ADC



Dynamic range and crosstalk after g.s.

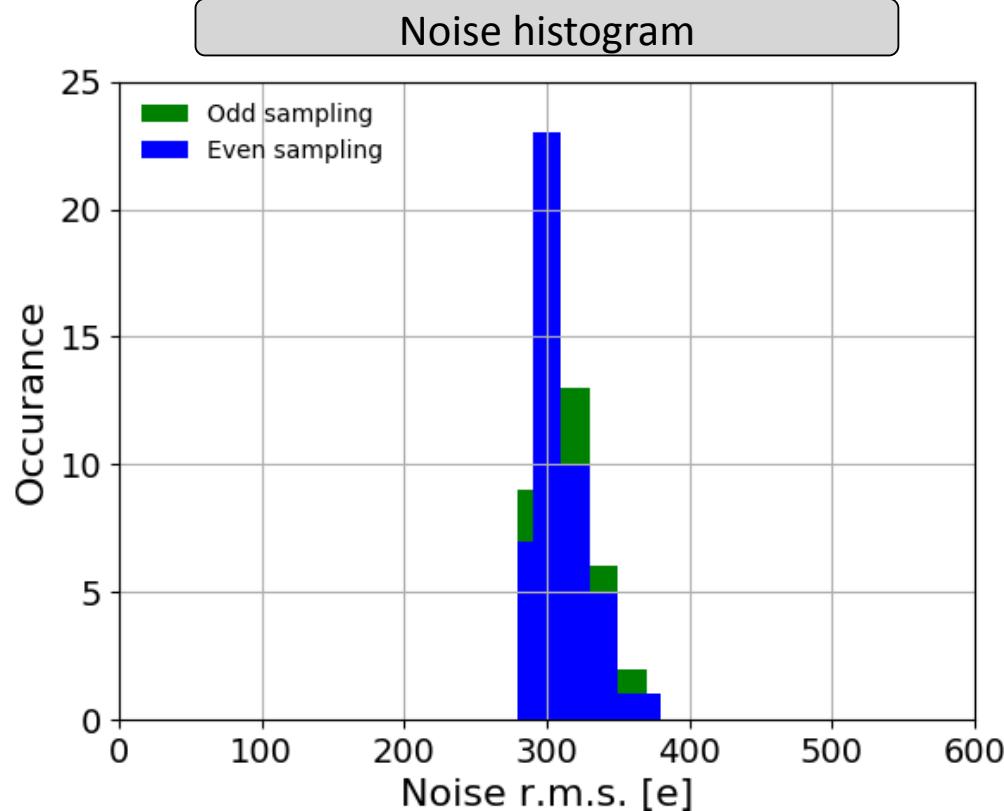
- Dynamic range: Infrared laser injection into center of a strip
 - G-1.5: 12570 x 12.4 keV photons, G-1.7: 11260 x 12.4 keV photons



- “Charge loss” for neighbouring strip after gain switching
 - G-1.5: $\sim 4 \times 12.4$ keV photons, G-1.7: $\sim 0.5 \times 12.4$ keV photons

Negligible “charge loss” after gain switching!

Gotthard-1.7 noise



Noise (HG0):

dark measurement

10 μ s integration time

G-1.5: 158 ± 5 e $^-$

G-1.7: 312 ± 25 e $^-$

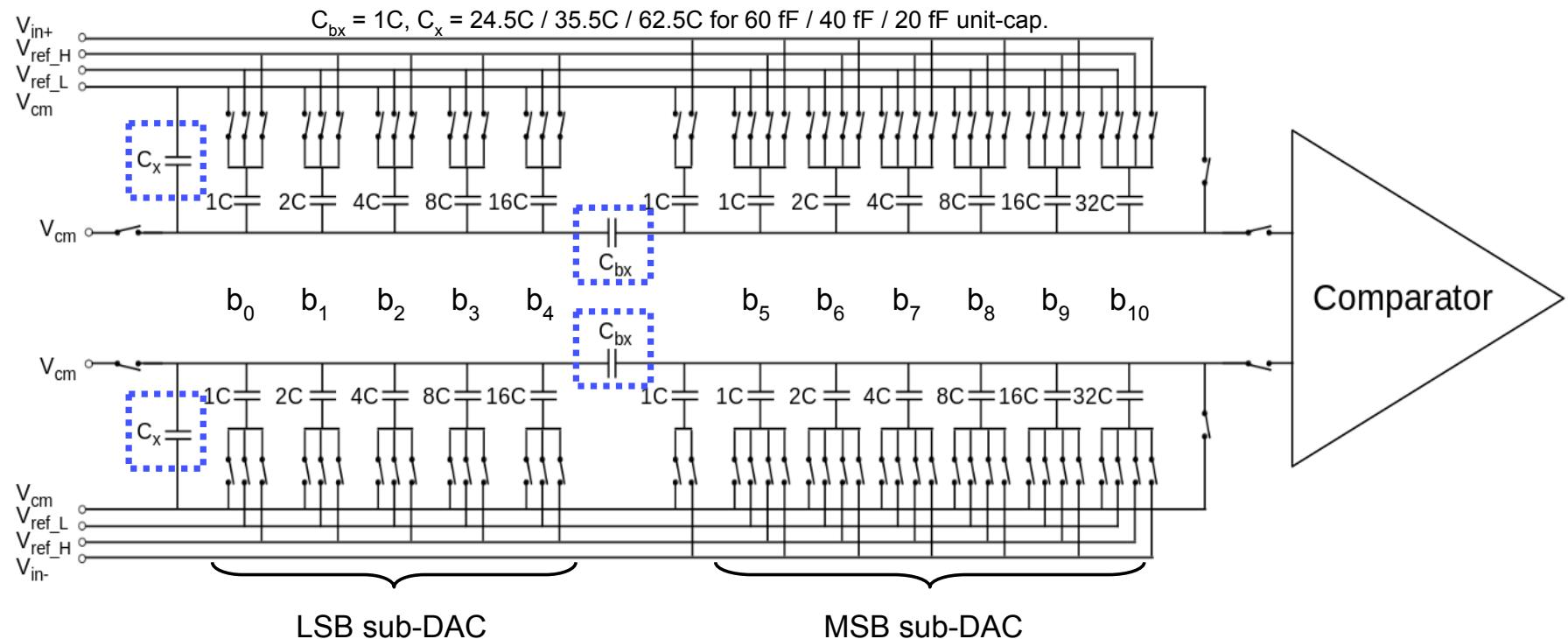
Causes: 1) Parasitic of pre-amplifier
2) Increased bandwidth

→ Optimize preamplifier design in G-1.8!

ADC status

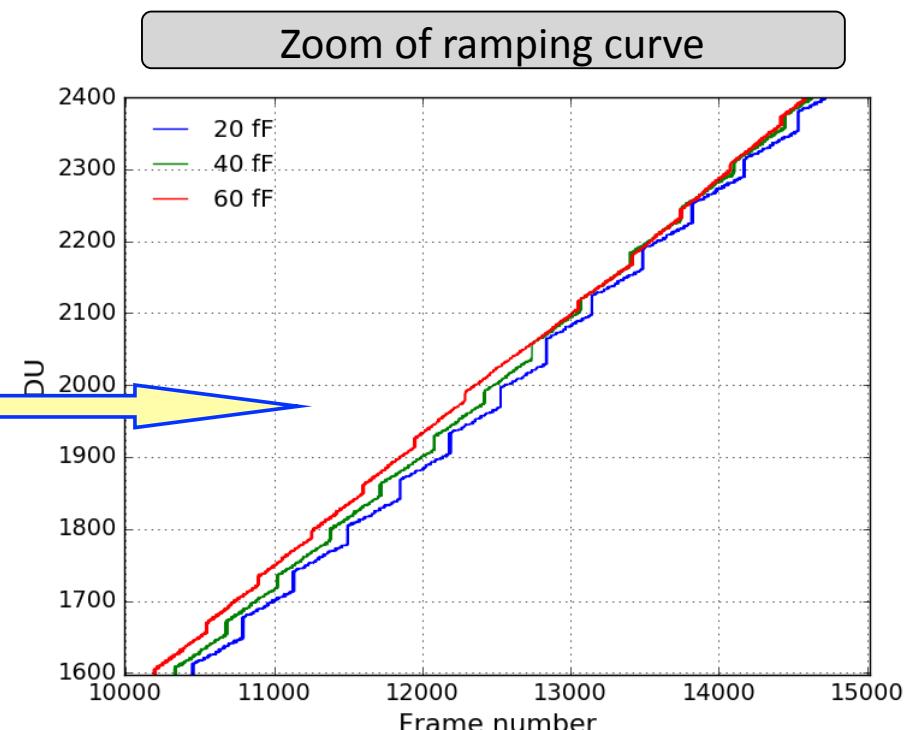
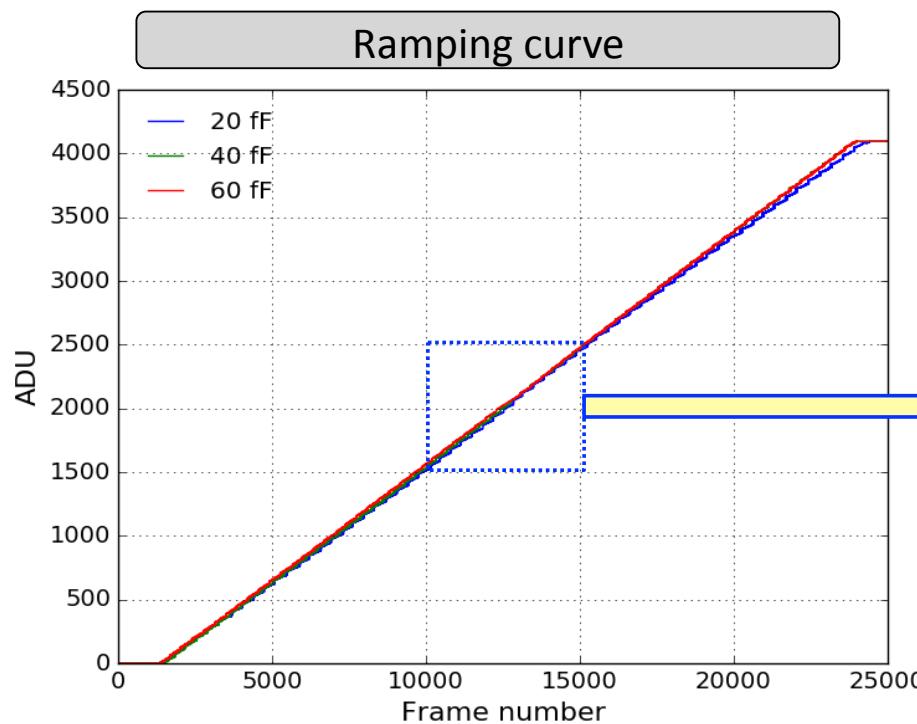
- 3 ADC test structure were submitted in 3 MPWs
- first one had too low sampling speed (reported last XDAC)
- second one
 - Missing codes
- third one submitted in March, will report next xdac

- 12-bit SAR (successive approximation) ADC
 - Split-capacitor DAC array → reduced total capacitance → charging time
 - Two sets of DAC arrays used
 - 3 variations of unit capacitance: $C = 20, 40, 60 \text{ fF}$



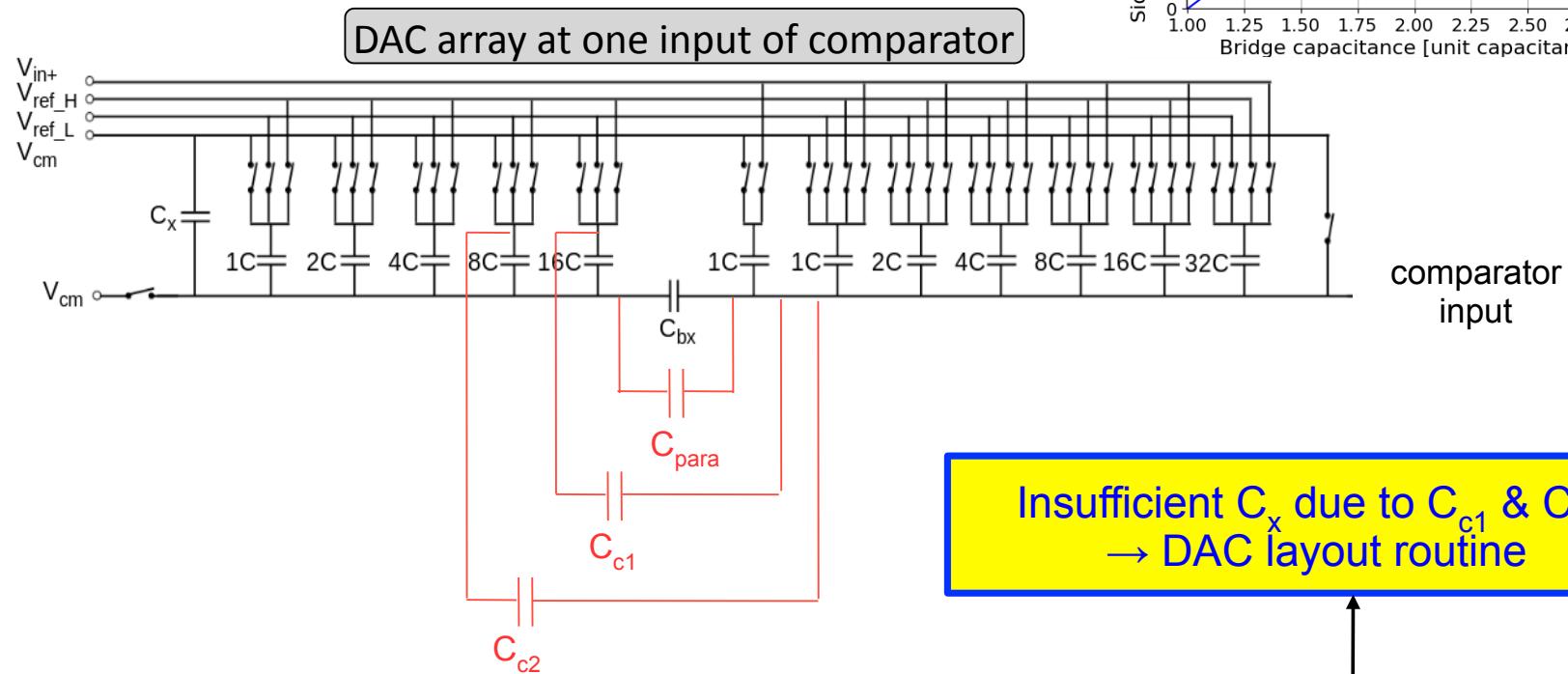
ADC 0.2 results

- Ramping curve: Linear voltage input covering entire range
 - Segmentation size: 64 ADU → transition from MSB-DAC to LSB-DAC
 - 20 fF: 28 ($28/64 = 43.75\%$ missing codes)
 - 40 fF: 16 ($16/64 = 25\%$ missing codes)
 - 60 fF: 12 ($12/64 = 18.75\%$ missing codes)



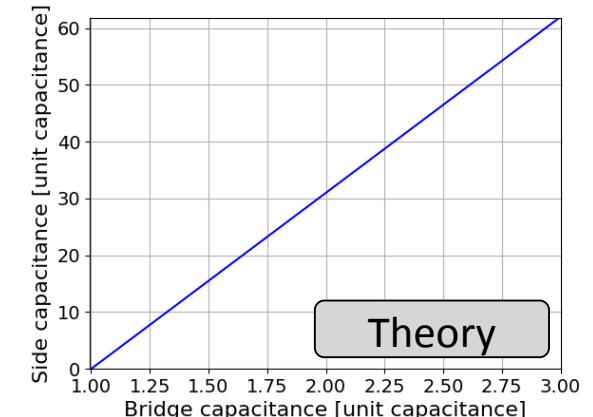
ADC 0.2 results II

- Causes: 1) Parasitics of bridge capacitance ($C_{bx} > 1C$)
- 2) Coupling LSB-DAC to comparator input



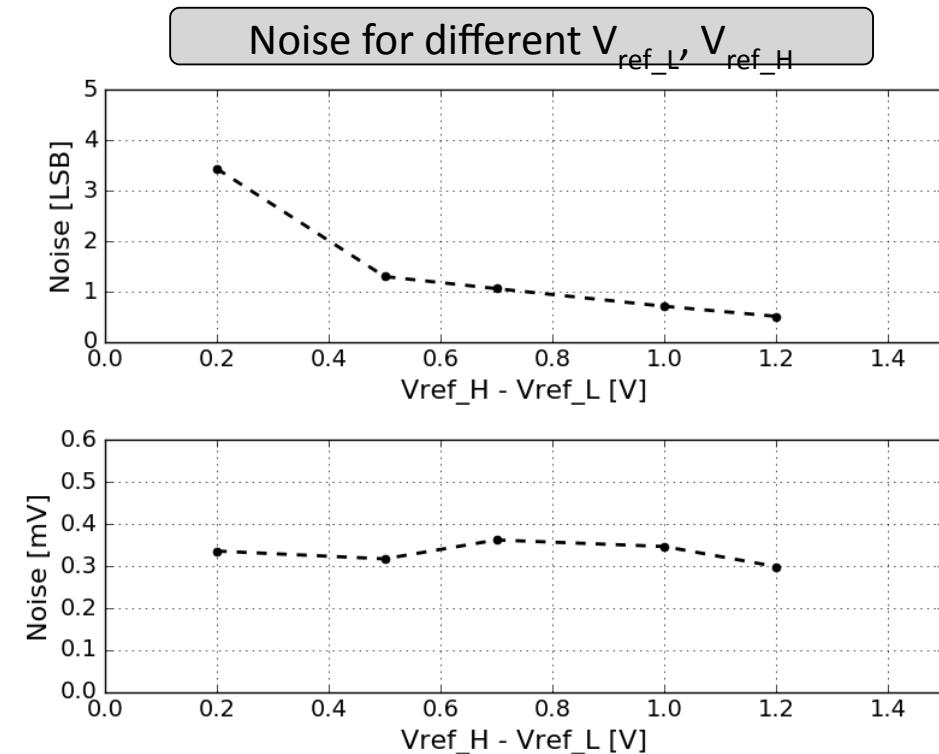
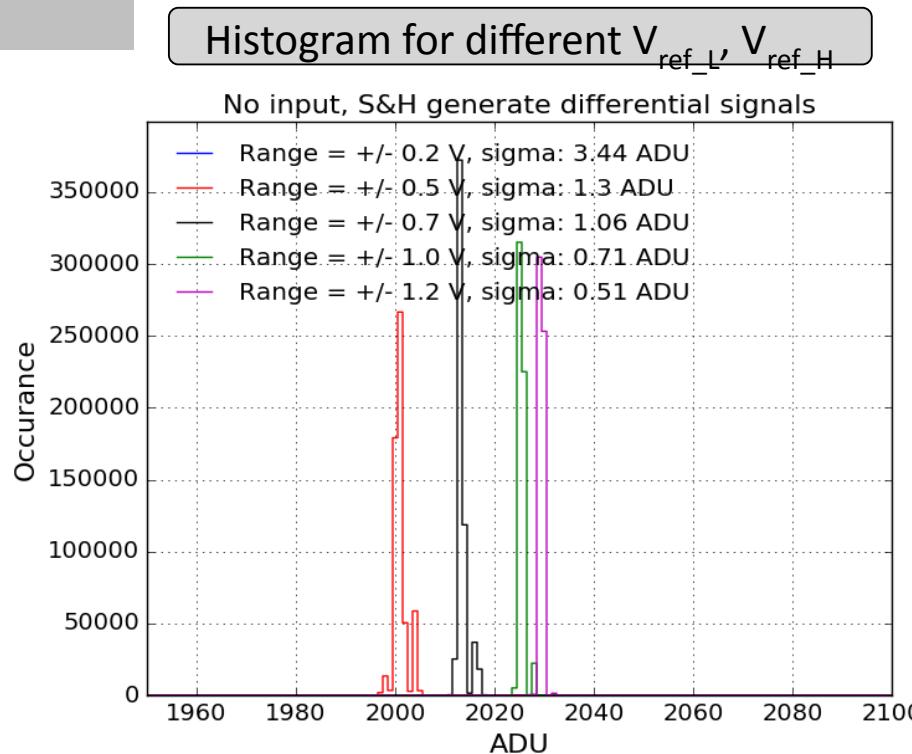
Unit. Cap C	C_{para}	C_{c1}	C_{c2}	C_x
20 fF	38 fF	4.2 fF	2.0 fF	62.5·C
40 fF	27 fF	8.2 fF	4.3 fF	35.5·C
60 fF	32 fF	7.5 fF	3.8 fF	24.5·C

10 times smaller with optimized layout in ADC-0.3



ADC 0.2 noise

- Internal/intrinsic noise of ADC-0.2: Switch + comparator + ...
 - No external input, S&H used to generate differential signals, $V_{cm} = 0.7 \text{ V}$
 - Noise extracted in terms of LSB, $1 \text{ LSB} = 2^*(V_{ref_H} - V_{ref_L}) / (2^{12}-1)$



- Intrinsic noise: $\sim 0.3 - 0.4 \text{ mV}$
- Good noise ($< 0.5 \text{ LSB}$) for $V_{ref_H} - V_{ref_L} \geq 1.2 \text{ V}$

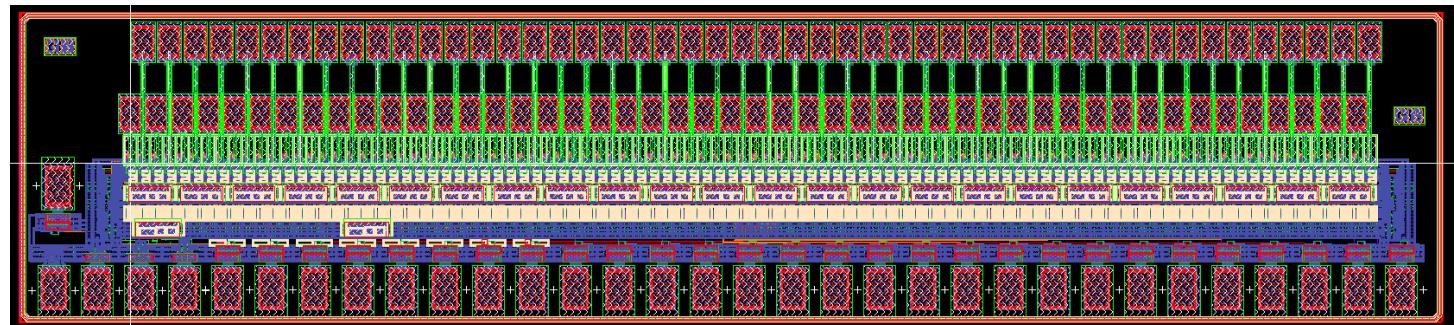
Gotthard 1.7 and ADC 0.2 summary

	Main issue	Reason	March MPW
G-1.7	noise	transistor size of pre-amplifier	variations of pre-amplifiers for optimization
ADC-0.2	noisy codes at two ends of input range	settling time to charge big capacitors	longer delay for charging big capacitors
		V_{cm} coupling	separated V_{cm} in sampling and comparison cycles
	missing codes	parasitic of bridge capacitor coupling from LSB-DAC to comparator input	adjustable side capacitance (2 bit configuration) improved DAC layout

Test structures submitted in MPW in March

- submission 10.03.2017:

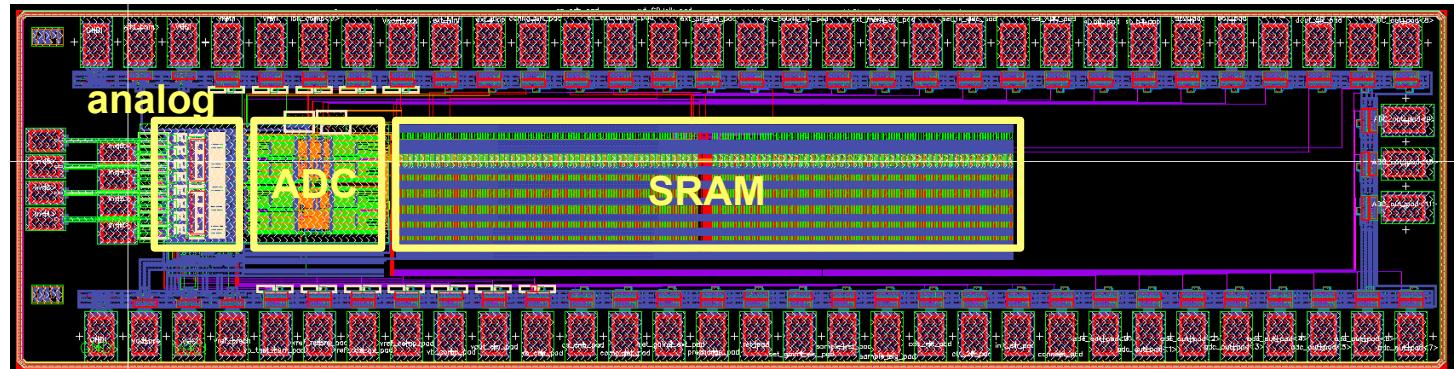
Analog front-end G-1.8:
8 variations,
analogue readout



ADC-0.3:
Unit cap. 20, 30, 40 fF,
Cx trimming



Complete chain G-1.9:
Analog + ADC + SRAM



Summary

- Gotthard-1.7 analogue FE characterized
 - Noise: 300 e⁻ for G0 → ok, but try to optimize noise in 1.8 FE
 - Capacitive cross talk after gain switching 0.5 12.4 keV ph
- ADC0.2 characterized
 - Effective <10 bits, missing codes
 - Problems understood ADC0.3 submitted
- Full chain submitted
- Next steps
 - Test structures from MPW: Gotthard1.8 FE, ADC0.3, full chain
 - Work on design for full chip (engineering run)
 - engineering run end of 17 / beginning 18
- first modules beginning 18